Search Notes	

Application/Control No.		Applicant(s)/Patent unde Reexamination	Applicant(s)/Patent under Reexamination	
	10/650,553	MANG ET AL.		
	Examiner	Art Unit		
	John L. Goodrow	1756		

	SEAR	CHED	
Class	Subclass	Date	Examiner
430	108.1	8/17/2005	JG
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	DATE	EXMR
inventor name search	8/17/2005	JG